

Notice of References Cited			Application/Control No.	Applicant(s)/Patent Under Reexamination ASAMI ET AL.	
			Examiner Patrick H. Mackey	Art Unit 3651	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,316,280 A	05-1994	Watkiss, Christopher R.	270/37
*	B	US-5,746,424 A	05-1998	Rutten et al.	270/37
*	C	US-6,022,011 A	02-2000	Hirose, Akira	270/37
*	D	US-6,276,677 B1	08-2001	Hommochi et al.	270/32
*	E	US-6,354,059 B1	03-2002	Yoshie et al.	53/117
*	F	US-6,568,668 B1	05-2003	Wakabayashi et al.	270/58.11
*	G	US-2004/0046304 A1	03-2004	Itou et al.	270/032
*	H	US-2004/0183246 A1	09-2004	Jung et al.	270/037
*	I	US-2004/0188911 A1	09-2004	McNamara et al.	270/058.08
*	J	US-6,799,759 B1	10-2004	McNamara et al.	270/58.08
K	US-				
L	US-				
M	US-				

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
N	JP 07069514 A		03-1995	Japan	FURUYA, TAKAO	B65H 37/04
O	JP 07157180 A		06-1995	Japan	AKIYOSHI et al.	B65H 37/04
P	JP 11286369 A		10-1999	Japan	IRIE, YOICHIRO	B65H 37/04
Q	JP 2001206626 A		07-2001	Japan	TAKAHASHI et al.	B65H 37/04
R						
S						
T						

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.